

CSD22206W -8V P 通道 NexFET™ 功率金属氧化物半导体场效应晶体管 (MOSFET)

1 特性

- 超低电阻
- 小尺寸封装 1.5mm x 1.5mm
- 无铅
- 栅极静电放电 (ESD) 保护
- 符合 RoHS 环保标准
- 无卤素
- 栅 - 源电压钳位

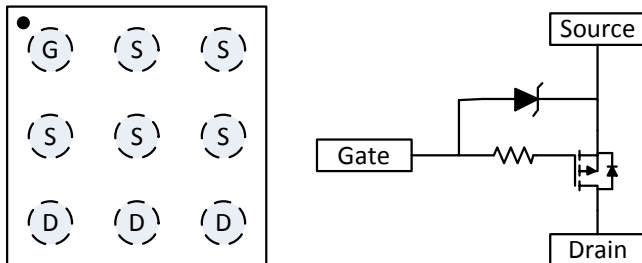
2 应用范围

- 负载开关 应用范围
- 电池管理
- 电池保护

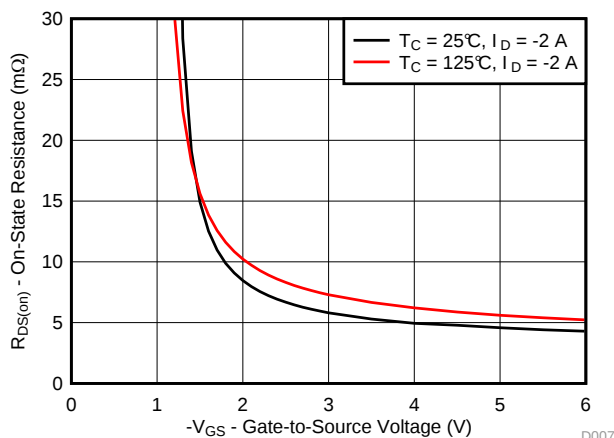
3 说明

这款 -8V、4.7mΩ、1.5mm × 1.5mm 器件设计用于在超薄且具有出色散热特性的超小外形尺寸封装内提供最低的导通电阻和栅极电荷。低导通电阻与小型封装尺寸和低高度结合在一起，使得此器件非常适合于电池供电运行的空间受限应用。

顶视图和电路配置



$R_{DS(on)}$ 与 V_{GS} 对比



产品概要

$T_A = 25^\circ\text{C}$		典型值	单位
V_{DS}	漏源电压	-8	V
Q_g	栅极电荷总量 (-4.5V)	11.2	nC
Q_{gd}	栅极电荷 (栅极到漏极)	1.8	nC
$R_{DS(on)}$	漏源导通电阻	$V_{GS} = -2.5\text{V}$	6.8
		$V_{GS} = -4.5\text{V}$	4.7
$V_{GS(th)}$	阈值电压	-0.7	V

器件信息

器件	数量	包装介质	封装	运输
CSD22206W	3000	7 英寸卷带	1.50mm × 1.50mm 晶圆级球状引脚栅格阵列 (BGA) 封装	卷带封装
CSD22206WT	250			

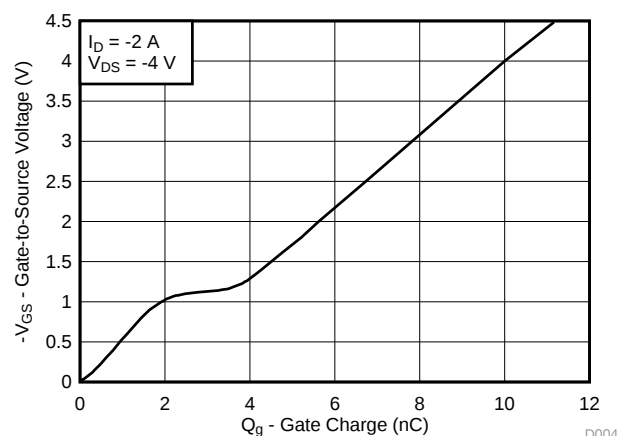
绝对最大额定值

$T_A = 25^\circ\text{C}$		值	单位
V_{DS}	漏源电压	-8	V
V_{GS}	栅源电压	-6	V
I_D	持续漏极电流 ⁽¹⁾	-5	A
	脉冲漏极电流 ⁽²⁾	-108	A
P_D	功率耗散	1.7	W
T_J, T_{stg}	工作结温, 储存温度	-55 至 150	°C

(1) 器件在 105°C 温度下运行。

(2) 典型 $R_{\theta JA} = 75^\circ\text{C/W}$ (安装于具有最大铜安装区域的 FR4 材料)，脉宽 $\leq 100\mu\text{s}$ ，占空比 $\leq 1\%$ 。

栅极电荷



目录

1	特性	1	6	器件和文档支持	7
2	应用范围	1	6.1	接收文档更新通知	7
3	说明	1	6.2	社区资源	7
4	修订历史记录	2	6.3	商标	7
5	Specifications	3	6.4	静电放电警告	7
5.1	Electrical Characteristics	3	6.5	Glossary	7
5.2	Thermal Information	3	7	机械、封装和可订购信息	8
5.3	Typical MOSFET Characteristics	4	7.1	CSD22206W 封装尺寸	8
			7.2	建议的焊盘图案	9

4 修订历史记录

日期	修订版本	注释
2017 年 5 月	*	初始发行版。

5 Specifications

5.1 Electrical Characteristics

 $T_A = 25^\circ\text{C}$ (unless otherwise stated)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC CHARACTERISTICS						
BV _{DSS}	Drain-to-source voltage	V _{GS} = 0 V, I _{DS} = −250 μA	−8			V
BV _{GSS}	Gate-to-source voltage	V _{DS} = 0 V, I _G = −250 μA	−6			V
I _{DSS}	Drain-to-source leakage current	V _{GS} = 0 V, V _{DS} = −6.4 V			−1	μA
I _{GSS}	Gate-to-source leakage current	V _{DS} = 0 V, V _{GS} = −6 V			−100	nA
V _{GS(th)}	Gate-to-source threshold voltage	V _{DS} = V _{GS} , I _{DS} = −250 μA	−0.4	−0.7	−1.05	V
R _{DS(on)}	Drain-to-source on resistance	V _{GS} = −2.5 V, I _{DS} = −2 A		6.8	9.1	mΩ
		V _{GS} = −4.5 V, I _{DS} = −2 A		4.7	5.7	
g _{fs}	Transconductance	V _{DS} = −0.8 V, I _{DS} = −2 A		20		S
DYNAMIC CHARACTERISTICS						
C _{ISS}	Input capacitance	V _{GS} = 0 V, V _{DS} = −4 V, f = 1 MHz		1750	2275	pF
C _{OSS}	Output capacitance			960	1250	pF
C _{RSS}	Reverse transfer capacitance			340	440	pF
R _G	Series gate resistance			30		Ω
Q _g	Gate charge total (−4.5 V)	V _{DS} = −4 V, I _D = −2 A		11.2	14.6	nC
Q _{gd}	Gate charge gate-to-drain			1.8		nC
Q _{gs}	Gate charge gate-to-source			2.1		nC
Q _{g(th)}	Gate charge at V _{th}			1.3		nC
Q _{OSS}	Output charge	V _{DS} = −4 V, V _{GS} = 0 V		7.2		nC
t _{d(on)}	Turnon delay time	V _{DS} = −4 V, V _{GS} = −4.5 V, I _{DS} = −2 A, R _G = 0 Ω		37		ns
t _r	Rise time			17		ns
t _{d(off)}	Turnoff delay time			118		ns
t _f	Fall time			45		ns
DIODE CHARACTERISTICS						
V _{SD}	Diode forward voltage	I _{DS} = −2 A, V _{GS} = 0 V	−0.69	−1.0		
Q _{rr}	Reverse recovery charge	V _{DS} = −4 V, I _F = −1 A, di/dt = 200 A/μs		24		nC
t _{rr}	Reverse recovery time			59		ns

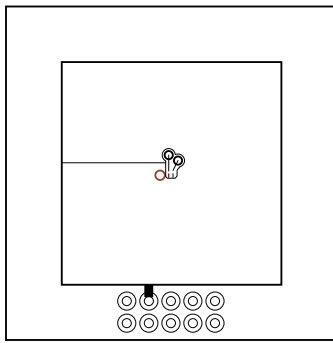
5.2 Thermal Information

 $T_A = 25^\circ\text{C}$ (unless otherwise stated)

THERMAL METRIC		TYPICAL VALUES	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance ⁽¹⁾	75	$^\circ\text{C}/\text{W}$
	Junction-to-ambient thermal resistance ⁽²⁾	230	

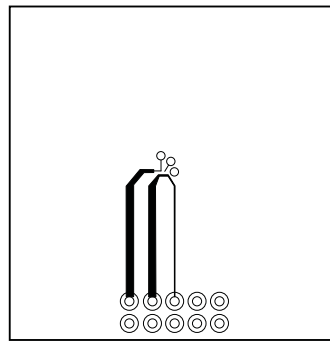
(1) Device mounted on FR4 material with 1-in² (6.45-cm²), 2-oz (0.071-mm) thick Cu.

(2) Device mounted on FR4 material with minimum Cu mounting area.



M0149-01

Typ $R_{\theta JA} = 75^{\circ}\text{C/W}$
when mounted on 1 in²
of 2-oz Cu.



M0150-01

Typ $R_{\theta JA} = 230^{\circ}\text{C/W}$
when mounted on
minimum pad area of
2-oz Cu.

5.3 Typical MOSFET Characteristics

$T_A = 25^{\circ}\text{C}$ (unless otherwise stated)

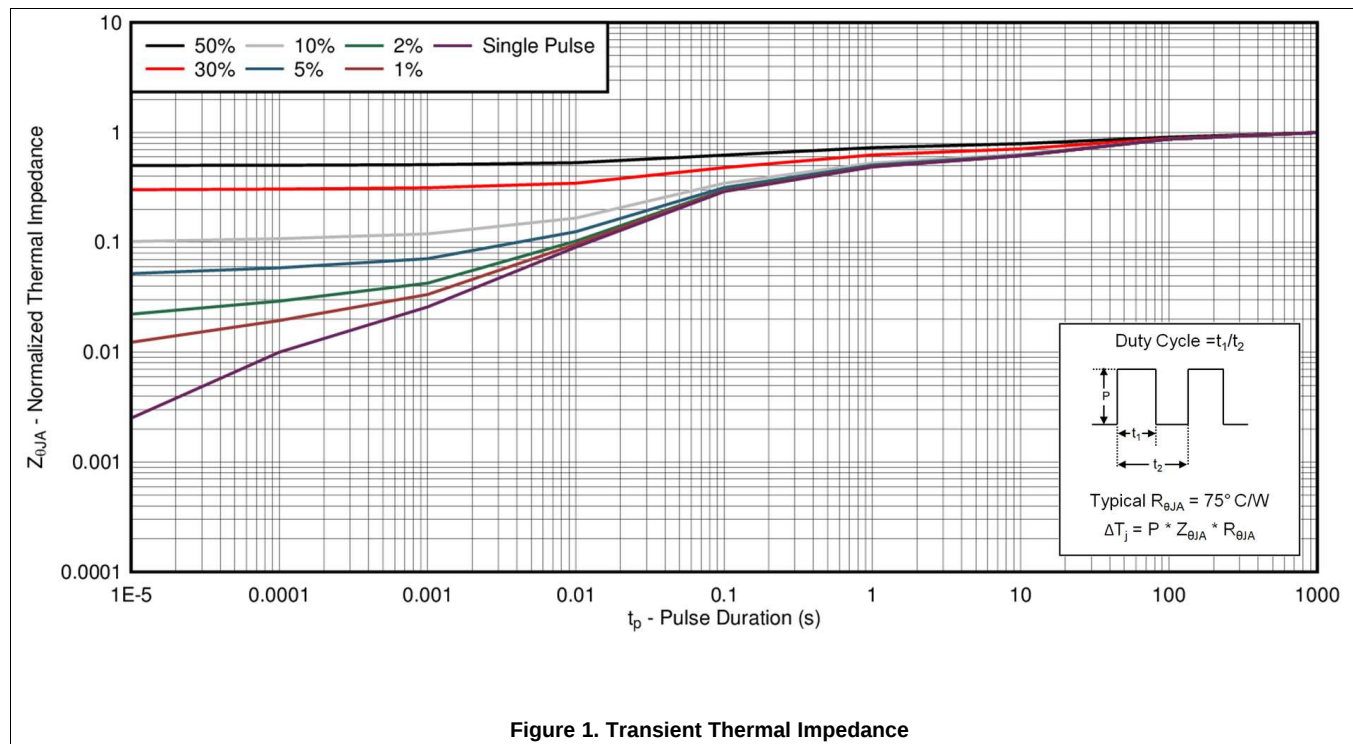


Figure 1. Transient Thermal Impedance

Typical MOSFET Characteristics (continued)

$T_A = 25^\circ\text{C}$ (unless otherwise stated)

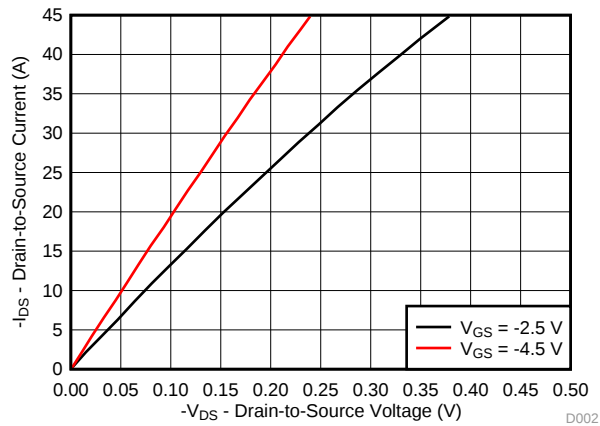


Figure 2. Saturation Characteristics

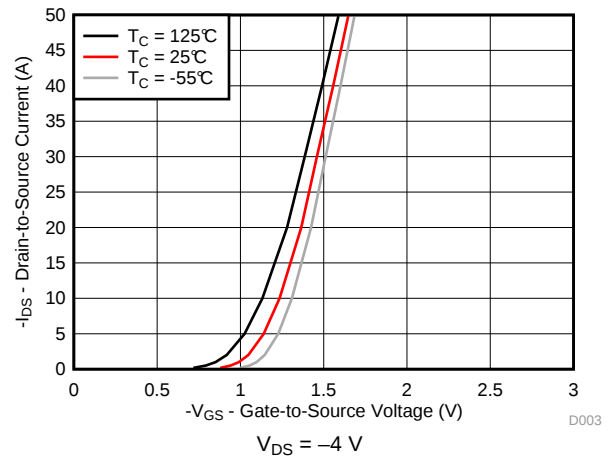


Figure 3. Transfer Characteristics

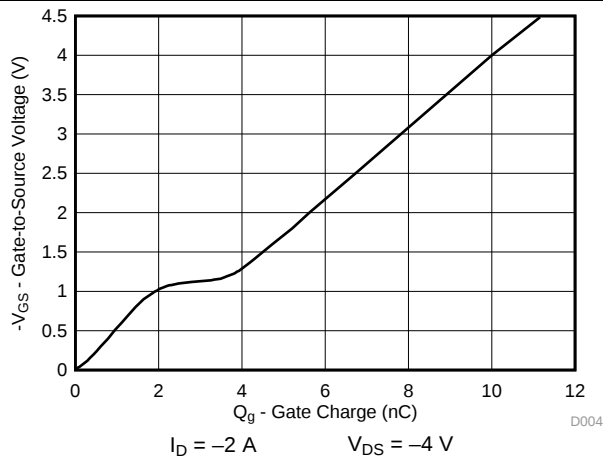


Figure 4. Gate Charge

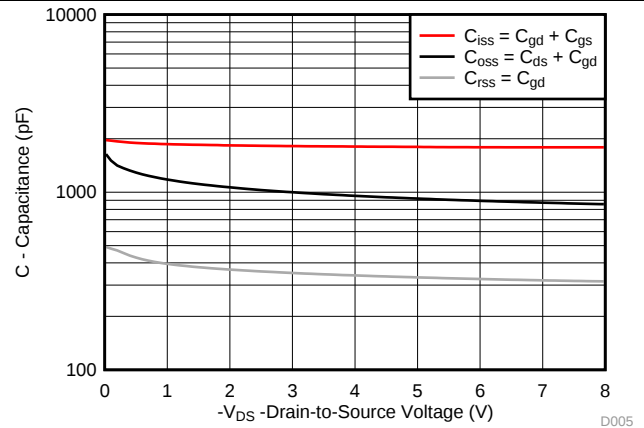


Figure 5. Capacitance

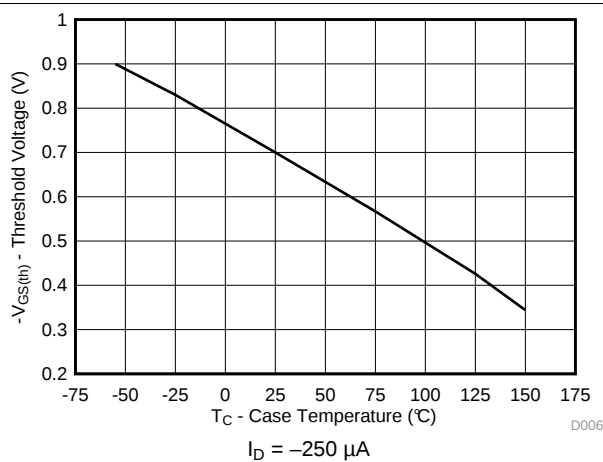


Figure 6. Threshold Voltage vs Temperature

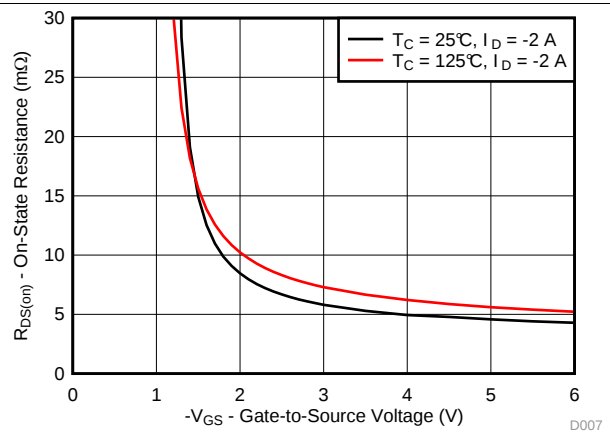


Figure 7. On-State Resistance vs Gate-to-Source Voltage

Typical MOSFET Characteristics (continued)

$T_A = 25^\circ\text{C}$ (unless otherwise stated)

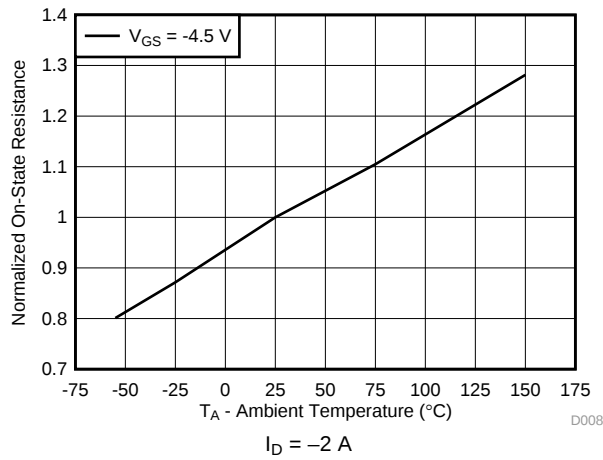


Figure 8. Normalized On-State Resistance vs Temperature

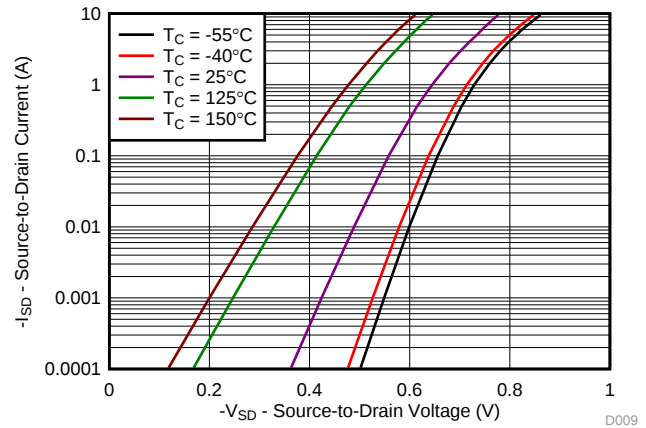


Figure 9. Typical Diode Forward Voltage

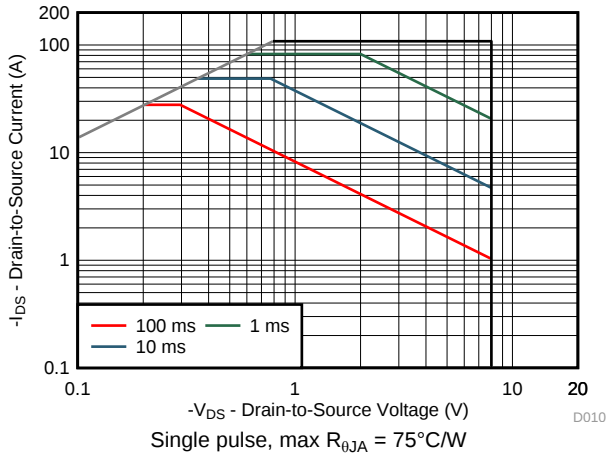


Figure 10. Maximum Safe Operating Area

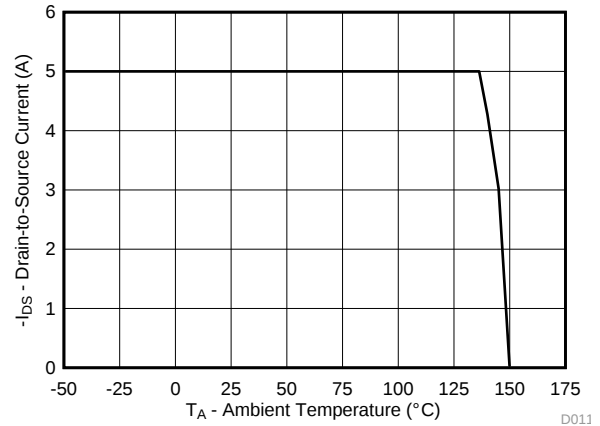


Figure 11. Maximum Drain Current vs Temperature

6 器件和文档支持

6.1 接收文档更新通知

要接收文档更新通知，请导航至 ti.com 上的器件产品文件夹。请单击右上角的通知我 进行注册，即可收到任意产品信息更改每周摘要。有关更改的详细信息，请查看任意已修订文档中包含的修订历史记录。

6.2 社区资源

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

TI E2E™ Online Community *TI's Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

6.3 商标

NexFET, E2E are trademarks of Texas Instruments.
All other trademarks are the property of their respective owners.

6.4 静电放电警告



这些装置包含有限的内置 ESD 保护。存储或装卸时，应将导线一起截短或将装置放置于导电泡棉中，以防止 MOS 门极遭受静电损伤。

6.5 Glossary

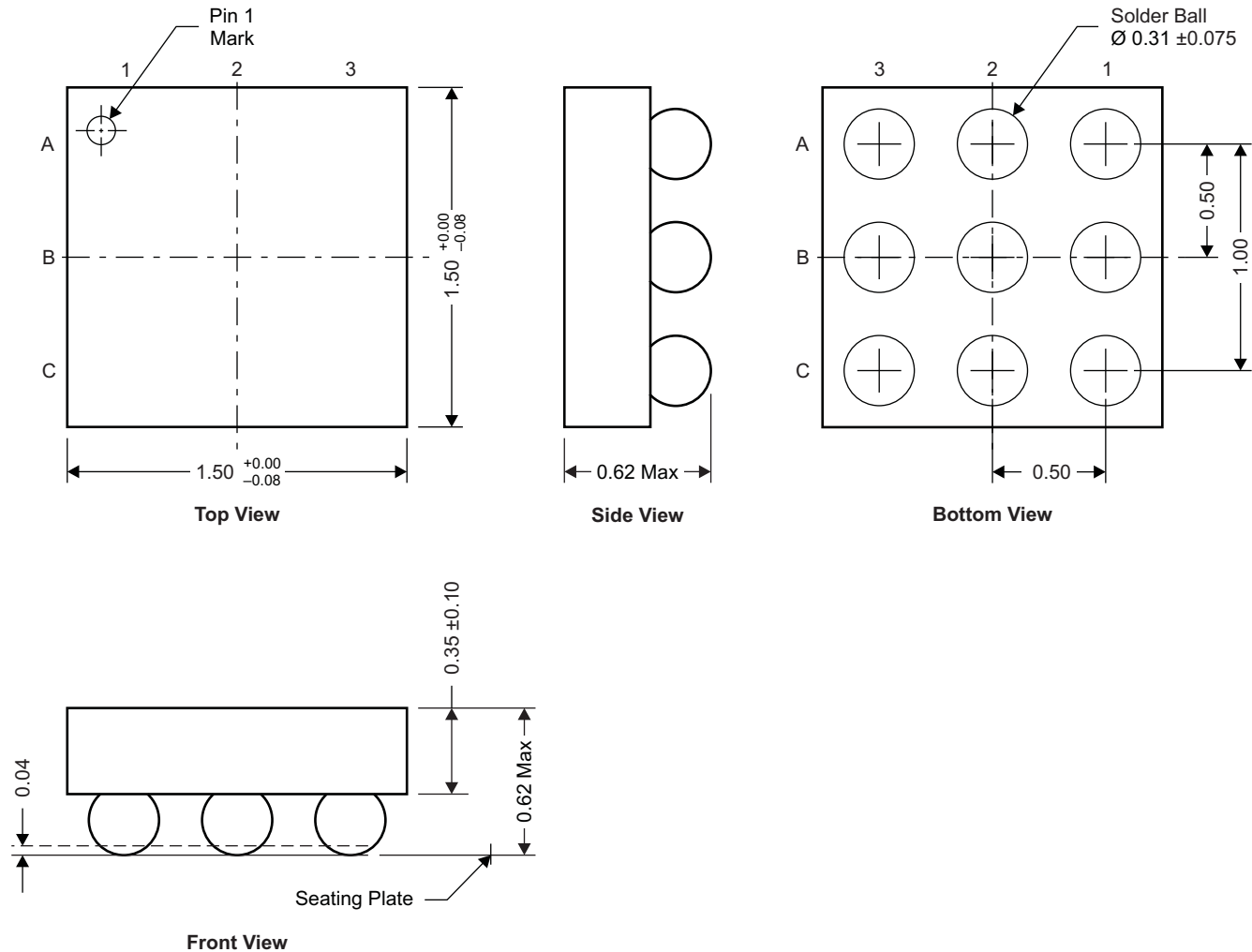
SLYZ022 — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

7 机械、封装和可订购信息

以下页面包括机械、封装和可订购信息。这些信息是指定器件的最新可用数据。这些数据发生变化时，我们可能不会另行通知或修订此文档。如欲获取此产品说明书的浏览器版本，请参见左侧的导航栏。

7.1 CSD22206W 封装尺寸



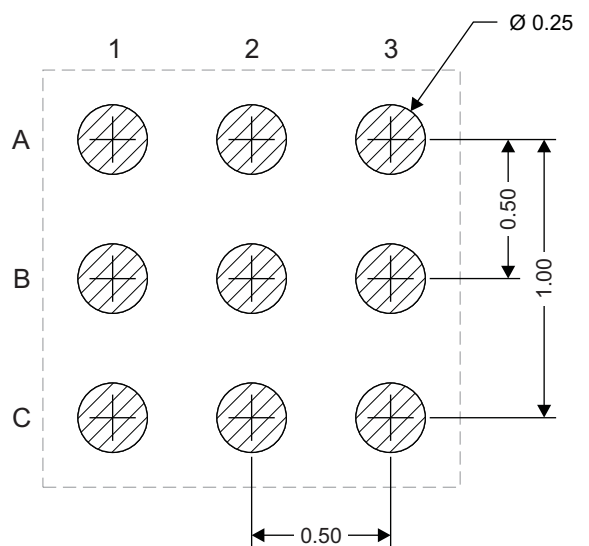
NOTE: 全部尺寸单位为 mm（除非另外注明）。

M0171-01

表 1. 引脚分配

位置	名称
A1	栅极
A2, A3, B1, B2, B3	源极
C1, C2, C3	漏极

7.2 建议的焊盘图案



M0172-01

NOTE: 全部尺寸单位为 mm (除非另外注明)。

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
CSD22206W	Active	Production	DSBGA (YZF) 9	3000 LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-55 to 150	22206
CSD22206W.B	Active	Production	DSBGA (YZF) 9	3000 LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-55 to 150	22206
CSD22206WT	Active	Production	DSBGA (YZF) 9	250 SMALL T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-55 to 150	22206
CSD22206WT.B	Active	Production	DSBGA (YZF) 9	250 SMALL T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-55 to 150	22206

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

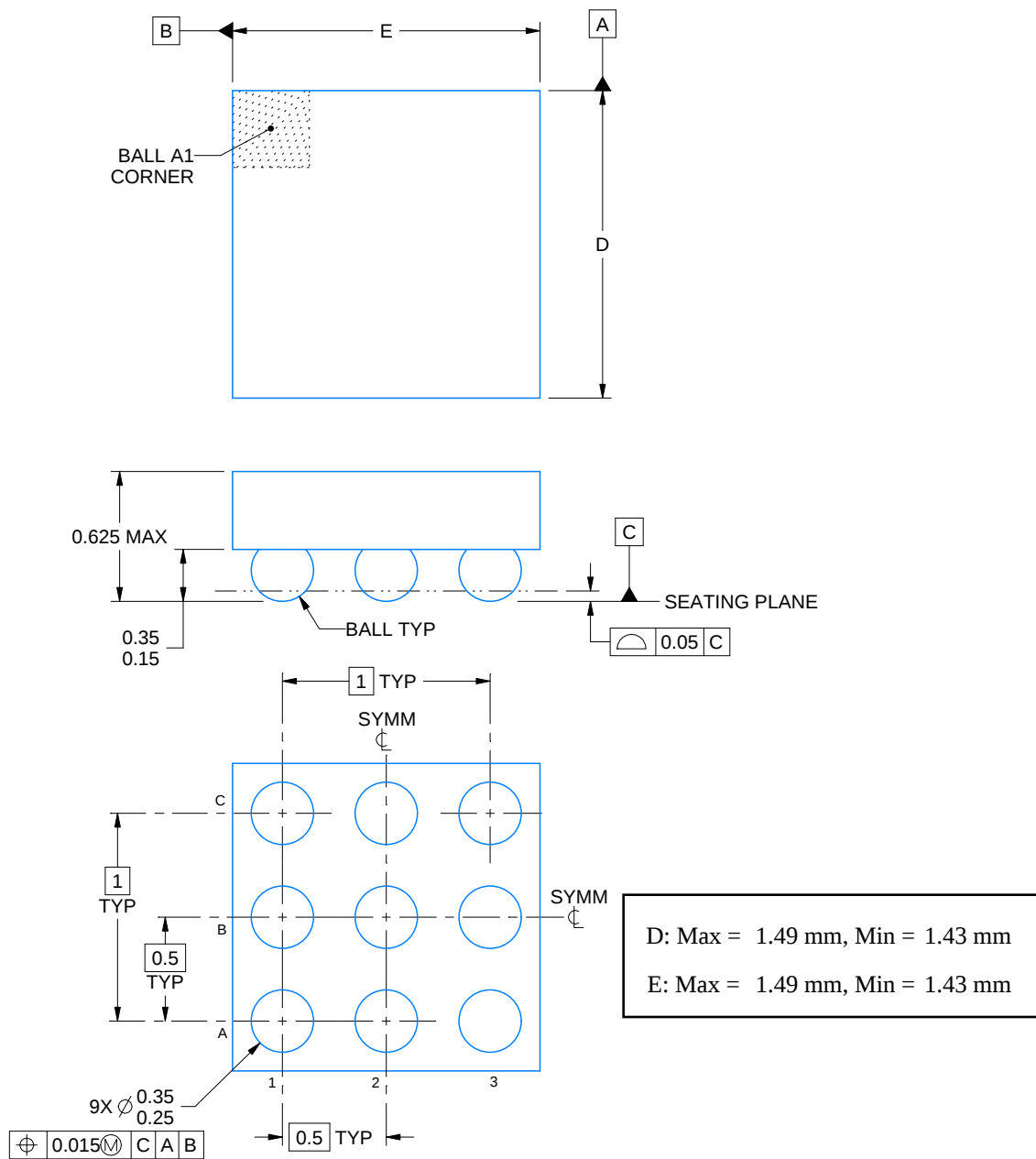
YZF0009



PACKAGE OUTLINE

DSBGA - 0.625 mm max height

DIE SIZE BALL GRID ARRAY



4219558/A 10/2018

NOTES:

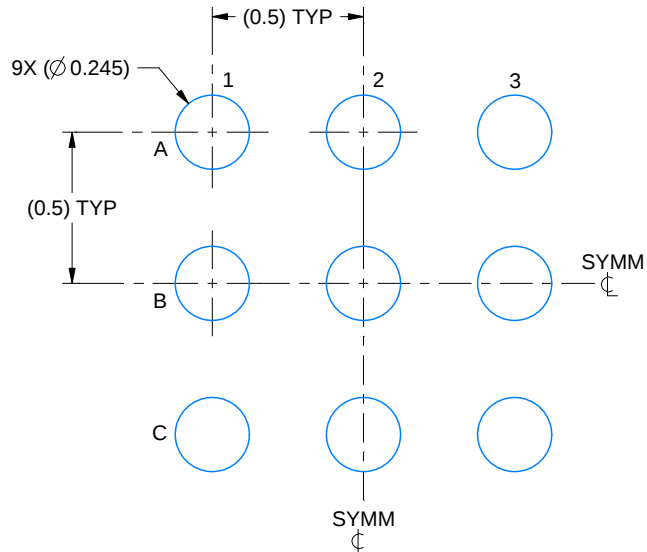
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.

EXAMPLE BOARD LAYOUT

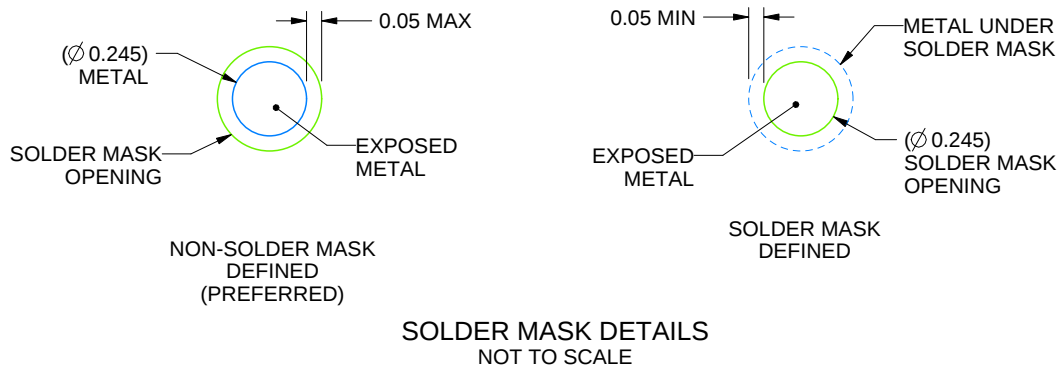
YZF0009

DSBGA - 0.625 mm max height

DIE SIZE BALL GRID ARRAY



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 40X



SOLDER MASK DETAILS
NOT TO SCALE

4219558/A 10/2018

NOTES: (continued)

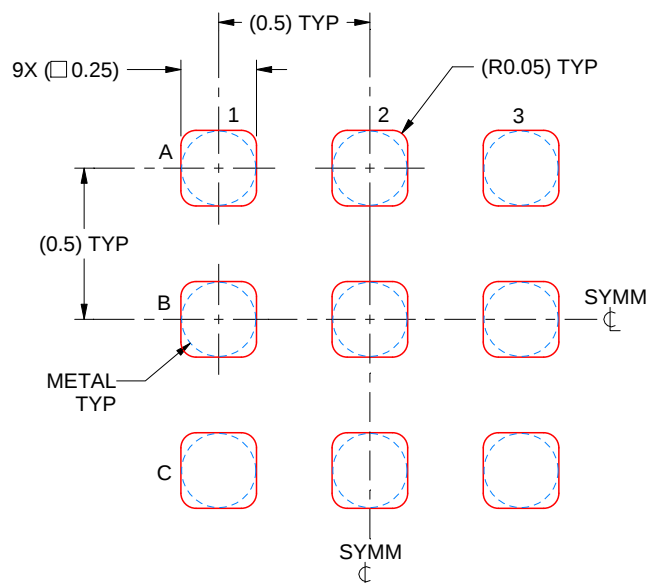
- Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. See Texas Instruments Literature No. SNVA009 (www.ti.com/lit/snva009).

EXAMPLE STENCIL DESIGN

YZF0009

DSBGA - 0.625 mm max height

DIE SIZE BALL GRID ARRAY



SOLDER PASTE EXAMPLE
BASED ON 0.1 mm THICK STENCIL
SCALE: 40X

4219558/A 10/2018

NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.

重要通知和免责声明

TI“按原样”提供技术和可靠性数据（包括数据表）、设计资源（包括参考设计）、应用或其他设计建议、网络工具、安全信息和其他资源，不保证没有瑕疵且不做任何明示或暗示的担保，包括但不限于对适销性、某特定用途方面的适用性或不侵犯任何第三方知识产权的暗示担保。

这些资源可供使用 TI 产品进行设计的熟练开发人员使用。您将自行承担以下全部责任：(1) 针对您的应用选择合适的 TI 产品，(2) 设计、验证并测试您的应用，(3) 确保您的应用满足相应标准以及任何其他功能安全、信息安全、监管或其他要求。

这些资源如有变更，恕不另行通知。TI 授权您仅可将这些资源用于研发本资源所述的 TI 产品的相关应用。严禁以其他方式对这些资源进行复制或展示。您无权使用任何其他 TI 知识产权或任何第三方知识产权。您应全额赔偿因在这些资源的使用中对 TI 及其代表造成的任何索赔、损害、成本、损失和债务，TI 对此概不负责。

TI 提供的产品受 [TI 的销售条款](#) 或 [ti.com](#) 上其他适用条款/TI 产品随附的其他适用条款的约束。TI 提供这些资源并不会扩展或以其他方式更改 TI 针对 TI 产品发布的适用的担保或担保免责声明。

TI 反对并拒绝您可能提出的任何其他或不同的条款。

邮寄地址：Texas Instruments, Post Office Box 655303, Dallas, Texas 75265
版权所有 © 2025，德州仪器 (TI) 公司